MINIMOS

A PROGRAM PACKAGE TO FACILITATE MOS DEVICE DESIGN AND ANALYSIS

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Abstract

We describe a program package for the twodimensional numerical exact simulation of planar MOS structures. The model is based upon the fundamental semiconductor equations (Poisson's equation, Continuity equations and current relations for electrons and holes). To ensure maximum flexibility and low computing costs sophisticated programming methods have been used. Dynamic memory management feasibility has been included to adjust automatically the memory require. ments to the number of grid points. Large parts of the solution routines are assembly coded and allow a very fast execution. The input processor syntax is easy to read and is shown to be fully compatible with a recently published proposal for a unified input syntax for CAD programs.

For one operating point typical execution times have been found to be between 15 and 60 seconds on a CDC Cyber 74 depending on bias values. The calculation of the current-voltage characteristics of a planar MOS transistor (10 operating points) in the subthreshold region can be performed in about 120 seconds CPU time.

The program has been successfully tested for widely varying devices, geometries and bias conditions. Reasonable agreement between theory and experiment has been obtained in almost all cases.